


<b>Search Notes</b>  	<b>Application/Control No.</b>  10810173	<b>Applicant(s)/Patent Under Reexamination</b>  CHIN ET AL.
	<b>Examiner</b>  Livedalen, Brian J	<b>Art Unit</b>  2878

SEARCHED			
Class	Subclass	Date	Examiner
250	231.1-231.18	1/23/2007	bl

SEARCH NOTES		
Search Notes	Date	Examiner
Database: East-USPGPUB, USPAT, USOCR, JPO, EPO, DERWENT, IBM_TDB	1/23/2007	bl
Consulted Thanh Luu in class 250	1/23/2007	bl

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner